

FAIRCHILD
SEMICONDUCTOR®

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FDMC2674

N-Channel UltraFET Trench® MOSFET

220V, 1A, 366mΩ

Features

- Max $r_{DS(on)}$ = 366mΩ at $V_{GS} = 10V, I_D = 1A$
- Typ $Q_g = 12.7nC$ at $V_{GS} = 10V$
- Low Miller charge
- Low Q_{rr} Body Diode
- Optimized efficiency at high frequencies
- UIS Capability (Single Pulse and Re-
petitive Pulse)
- RoHS Compliant

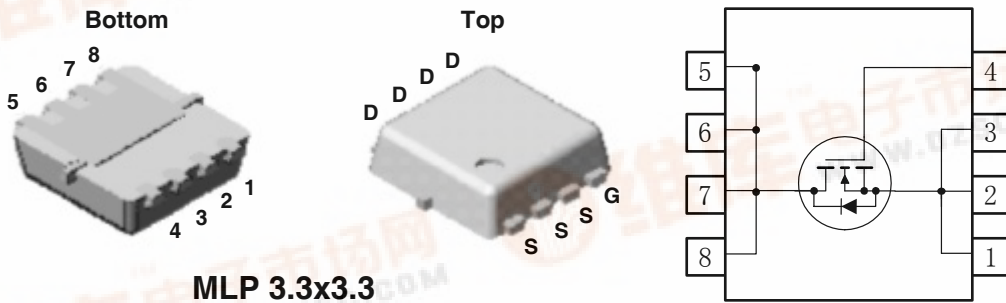


General Description

UltraFET® device combines characteristics that enable benchmark efficiency in power conversion applications. Optimized for $r_{DS(on)}$, low ESR, low total and Miller gate charge, these devices are ideal for high frequency DC to DC converters.

Applications

- DC/DC converters and Off-Line UPS
- Distributed Power Architectures



MLP 3.3x3.3

MOSFET Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

| Symbol | Parameter | Ratings | Units |
|----------------|--|------------|-------|
| V_{DS} | Drain to Source Voltage | 220 | V |
| V_{GS} | Gate to Source Voltage | ±20 | V |
| I_D | Drain Current -Continuous | 1 | A |
| | -Pulsed | 13.8 | |
| E_{AS} | Single Pulse Avalanche Energy (Note 3) | 13 | mJ |
| P_D | Power Dissipation for Single Operation | 2.4 | W |
| T_J, T_{STG} | Operating and Storage Temperature | -55 to 150 | °C |

Thermal Characteristics

| | | | |
|-----------------|---|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 52 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1b) | 108 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|---------------|-----------|------------|------------|
| FDMC2674 | FDMC2674 | MLP 3.3 x 3.3 | 7" | 12mm | 3000 units |

FDMC2674 N-Channel UltraFET Trench® MOSFET



Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

Off Characteristics

| | | | | | | |
|--------------------------------------|---|---|-----|-----|-----------|----------------------|
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ | 220 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\mu\text{A}$, referenced to 25°C | | 248 | | mV/ $^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 176\text{V}, V_{GS} = 0\text{V}$ | | | 1 | μA |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20\text{V}$, | | | ± 100 | nA |

On Characteristics (Note 2)

| | | | | | | |
|--|--|---|---|-------|-----|----------------------|
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ | 2 | 3.4 | 4 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\mu\text{A}$, referenced to 25°C | | -10.2 | | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$ | Drain to Source On Resistance | $V_{GS} = 10\text{V}, I_D = 1\text{A}$ | | 305 | 366 | m Ω |
| | | $V_{GS} = 10\text{V}, I_D = 1\text{A}, T_J = 150^\circ\text{C}$ | | 678 | 814 | |

Dynamic Characteristics

| | | | | | | |
|-----------|------------------------------|---|--|-----|------|----|
| C_{iss} | Input Capacitance | $V_{DS} = 100\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | | 880 | 1180 | pF |
| C_{oss} | Output Capacitance | | | 70 | 95 | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 11 | 20 | pF |

Switching Characteristics (Note 2)

| | | | | | | |
|--------------|----------------------------|--|--|------|----|----|
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 100\text{V}, I_D = 1\text{A}$ $V_{GS} = 10\text{V}, R_{GS} = 2.4\Omega$ | | 9 | 18 | ns |
| t_r | Rise Time | | | 13 | 23 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 15 | 27 | ns |
| t_f | Fall Time | | | 21 | 34 | ns |
| Q_g | Total Gate Charge at 10V | $V_{DD} = 15\text{V}, V_{GS} = 10\text{V}, I_D = 1\text{A}, I_G = 1.0\text{mA}$ | | 12.7 | 18 | nC |
| Q_{gs} | Gate to Source Gate Charge | | | 3.8 | | nC |
| Q_{gd} | Gate to Drain Charge | | | 2.9 | | nC |

Drain-Source Diode Characteristics

| | | | | | | |
|----------|---------------------------------------|--|--|-----|-----|----|
| V_{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0\text{V}, I_S = 1\text{A}$ | | 0.8 | 1.5 | V |
| t_{rr} | Reverse Recovery Time | $I_F = 1\text{A}, di/dt = 100\text{A}/\mu\text{s}$ | | | 60 | ns |
| Q_{rr} | Reverse Recovery Charge | $I_F = 1\text{A}, di/dt = 100\text{A}/\mu\text{s}$ | | | 109 | nC |

Notes:

1: $R_{\theta JA}$ is determined with the device mounted on a 1in² oz.copper pad on a 1.5x1.5 in board of FR-4 material . $R_{\theta JC}$ are guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



a. $52^\circ\text{C}/\text{W}$ when mounted on a 1 in² pad of 2 oz copper



b. $108^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper

2: Pulse Test:Pulse Width < 300 μs , Duty Cycle < 2.0%.
3: Starting $T_J = 25^\circ\text{C}$, L = 3mH, $I_{AS} = 3\text{A}$, $V_{DD} = 50\text{V}$, $V_{GS} = 10\text{V}$.

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

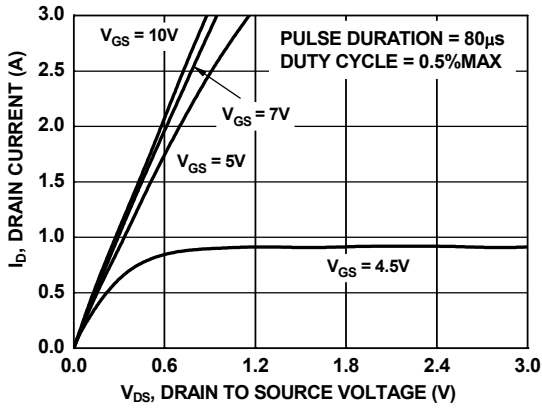


Figure 1. On Region Characteristics

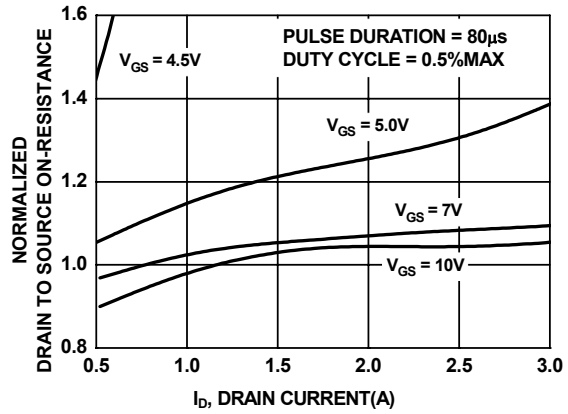


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

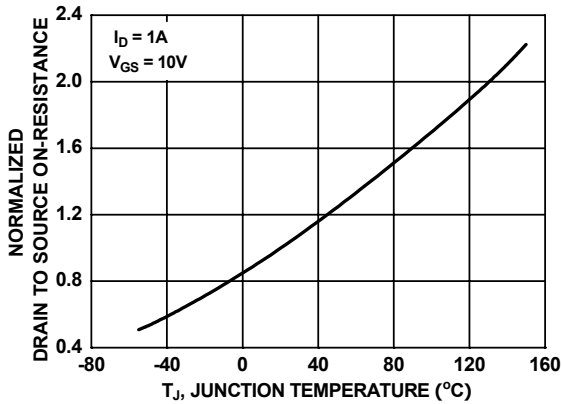


Figure 3. Normalized On Resistance vs Junction Temperature

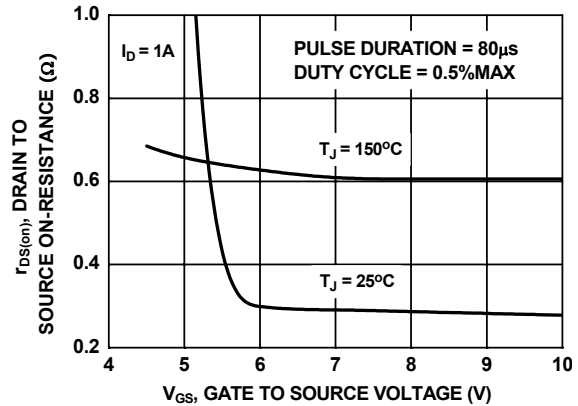


Figure 4. On-Resistance vs Gate to Source Voltage

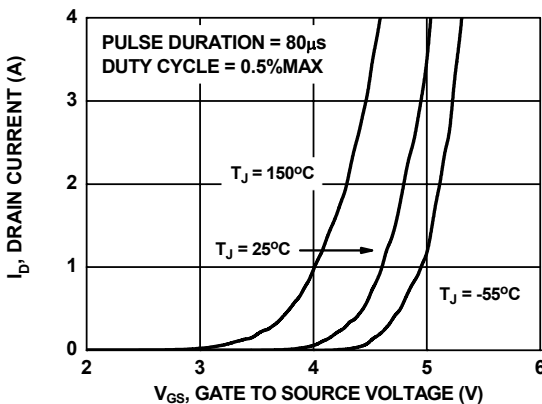


Figure 5. Transfer Characteristics

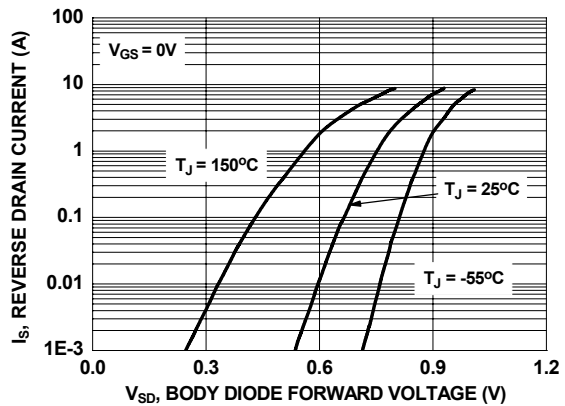


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

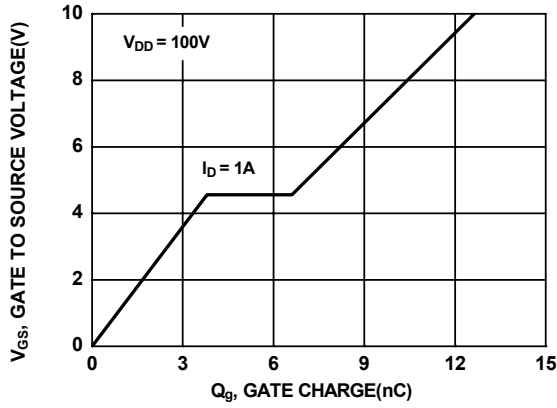


Figure 7. Gate Charge Characteristics

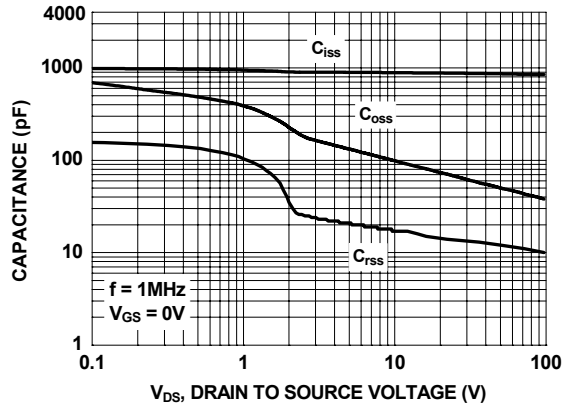


Figure 8. Capacitance vs Drain to Source Voltage

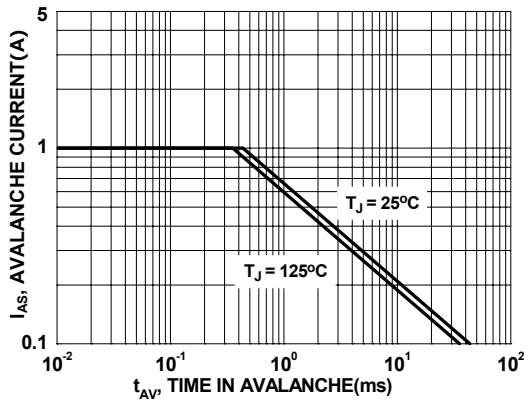


Figure 9. Unclamped Inductive Switching Capability

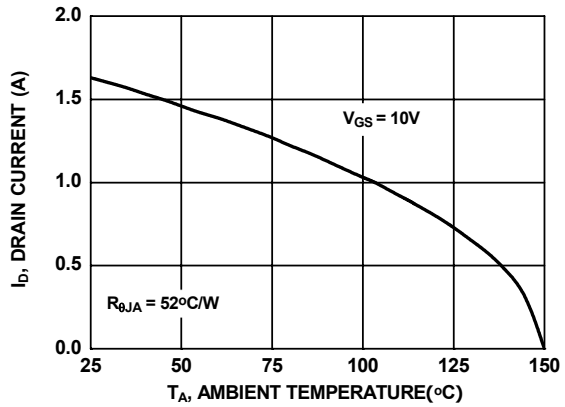


Figure 10. Maximum Continuous Drain Current vs Ambient Temperature

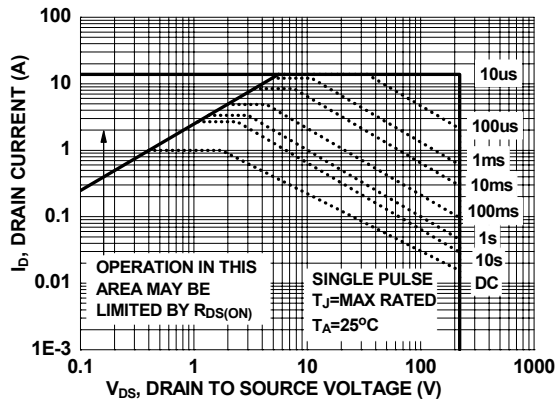


Figure 11. Forward Bias Safe Operating Area

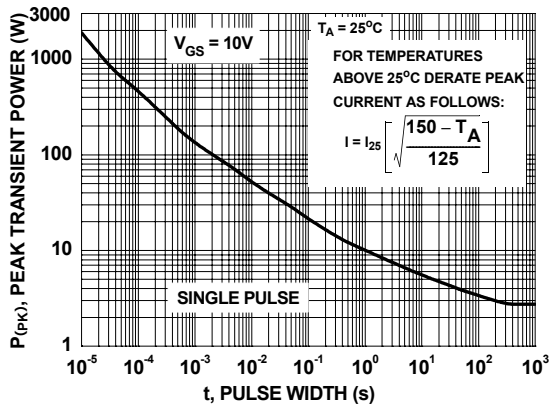


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

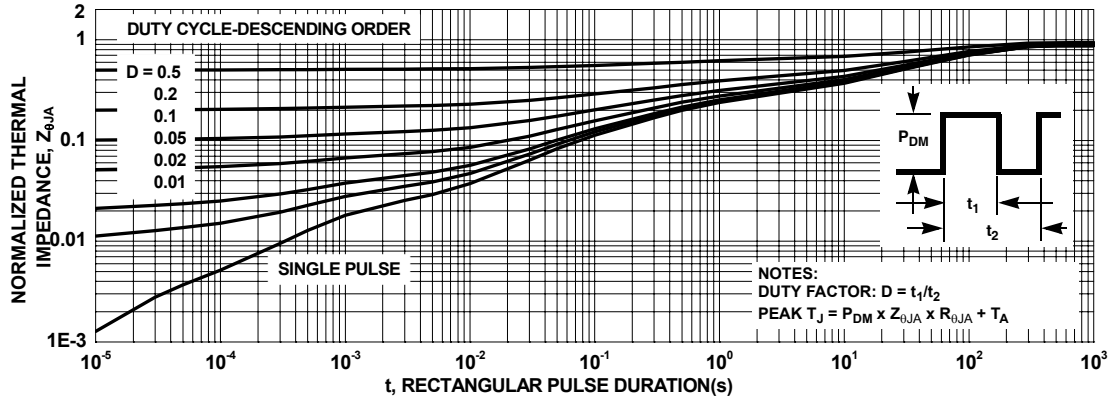


Figure 13. Transient Thermal Response Curve

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